Application No.: 10/709,723

Docket No.: 22171-00016-US1

This listing of claims will replace all prior versions and listings of claims in the application:

LISTING OF CLAIMS:

Please do not

1. (Previously presented)

enter in the device, the probe device comprising:

file.

an insulative body incl

at least one supporter comprise

body, wherein the supporter comprise (Previously presented) A probe device for electrically testing an integrated circuit

Emily chan 8/8/05

an insulative body including at least one opening;

at least one supporter positioned inside the at least one opening of the insulative body, wherein the supporter comprises a helical spring with a spiral coil extending substantially in a same plane;

a probe positioned substantially at a center of the supporter, wherein the probe is arranged to electrically connect to a pad of the integrated circuit device during testing; and a conductive wire positioned in the insulative body and electrically connected to the supporter.

- 2. (Currently amended) The probe device of Claim 1, further comprising two supporters positioned substantially in parallel with each other inside the at least one opening of the insulative body.
 - 3. (Canceled).
 - 4. (Canceled)
 - 5. (Canceled).
 - б. (Canceled).
 - 7. (Canceled).